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Team Nexperia

N-channel TrenchPLUS standard level FET

Rev. 02 — 19 February 2009

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using TrenchMOS technology. The devices include TrenchPLUS diodes for ElectroStatic Discharge (ESD) protection and temperature sensing. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features and benefits

- Allows responsive temperature monitoring due to integrated temperature sensor
- Electrostatically robust due to integrated protection diodes

1.3 Applications

- Automotive and general purpose power switching
- Electrical Power Assisted Steering (EPAS)

1.4 Quick reference data

Table 1. Quick reference

- Low conduction losses due to low on-state resistance
- Q101 compliant
- Suitable for standard level gate drive sources
- Fan control
- Variable Valve Timing for engines

Table 1.	QUICK reference						
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	55	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 2</u> ; see <u>Figure 3</u> ;	[1]	-	-	140	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	-	272	W
Static ch	aracteristics						
R_{DSon}	drain-source on-state resistance	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \; V; \; I_{D} = 50 \; A; \\ T_{j} = 25 \; ^{\circ}C \end{array}$		-	5.8	7	mΩ
Avalanch	ne ruggedness						
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$ \begin{split} I_D &= 68 \text{ A}; \text{V}_{\text{sup}} \leq 55 \text{ V}; \\ R_{\text{GS}} &= 50 \Omega; \text{V}_{\text{GS}} = 10 \text{V}; \\ T_{j(\text{init})} &= 25 ^{\circ}\text{C}; \text{ unclamped} \end{split} $		-	-	460	mJ

[1] Current is limited by power dissipation chip rating



N-channel TrenchPLUS standard level FET

2. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	А	anode	mb	
3	D	drain		
4	К	cathode	i i ''	(☆ └ 平)
5	S	source		
mb	D	mounting base; connected to		S K
		drain	SOT426 (D2PAK)	mb/317

3. Ordering information

Table 3. Ordering information Type number Package Name Description Version BUK7107-55ATE D2PAK plastic single-ended surface-mounted package (D2PAK); 5 leads (one soft26 lead cropped)

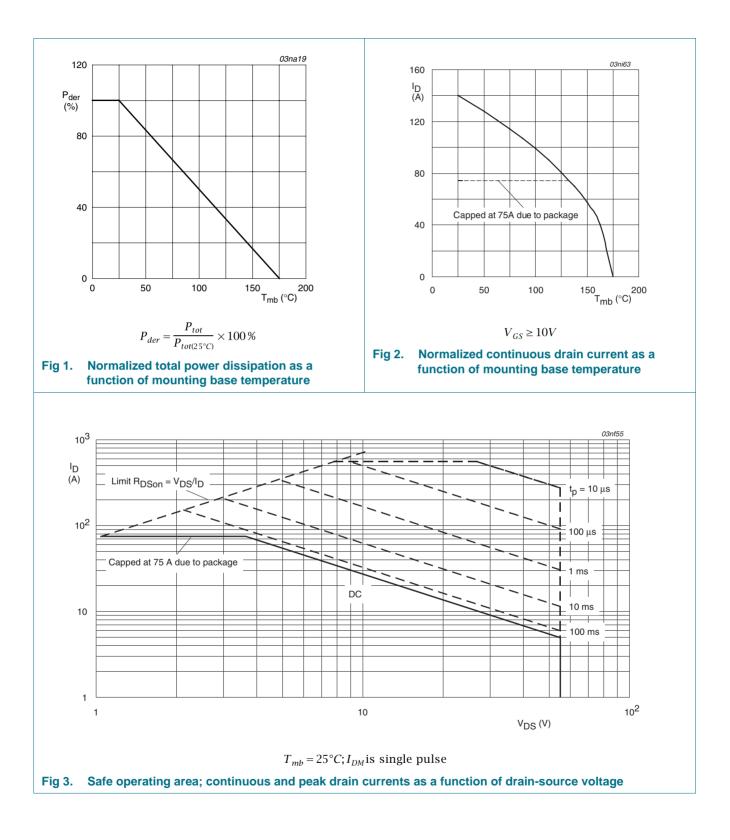
4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

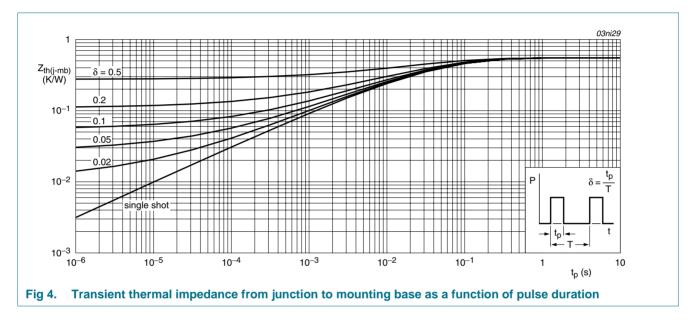
Symbol	Parameter	Conditions		Min	Max	Uni
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	55	V
V _{GS}	gate-source voltage			-20	20	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; see <u>Figure 2</u> ;		-	75	А
		see <u>Figure 3;</u>	[1]	-	140	А
		T _{mb} = 100 °C; V _{GS} = 10 V;	[1]	-	75	А
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \le 10 \ \mu$ s; pulsed		-	560	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 1</u>		-	272	W
I _{GS(CL)}	gate-source clamping	continuous		-	10	mA
	current	pulsed; $t_p = 5 \text{ ms}; \delta = 0.01$		-	50	mA
V _{isol(FET-TSD)}	FET to temperature sense diode isolation voltage			-100	100	V
T _{stg}	storage temperature			-55	175	°C
Тj	junction temperature			-55	175	°C
V _{DGS}	drain-gate voltage	I _{DG} = 250 μA		-	55	V
Source-drain	n diode					
I _S	source current	T _{mb} = 25 °C		-	140	А
				-	75	А
I _{SM}	peak source current	$t_p \le 10 \ \mu s$; pulsed; $T_{mb} = 25 \ ^{\circ}C$		-	560	А
Avalanche r	uggedness					
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$ I_D = 68 \text{ A}; \text{V}_{\text{sup}} \leq 55 \text{ V}; \text{R}_{\text{GS}} = 50 \Omega; \text{V}_{\text{GS}} = 10 \text{ V}; \\ \text{T}_{j(\text{init})} = 25 ^{\circ}\text{C}; \text{ unclamped} $		-	460	mJ
Electrostatio	Discharge					
V _{ESD}	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 k Ω		-	6	kV

[1] Current is limited by power dissipation chip rating.



5. Thermal characteristics

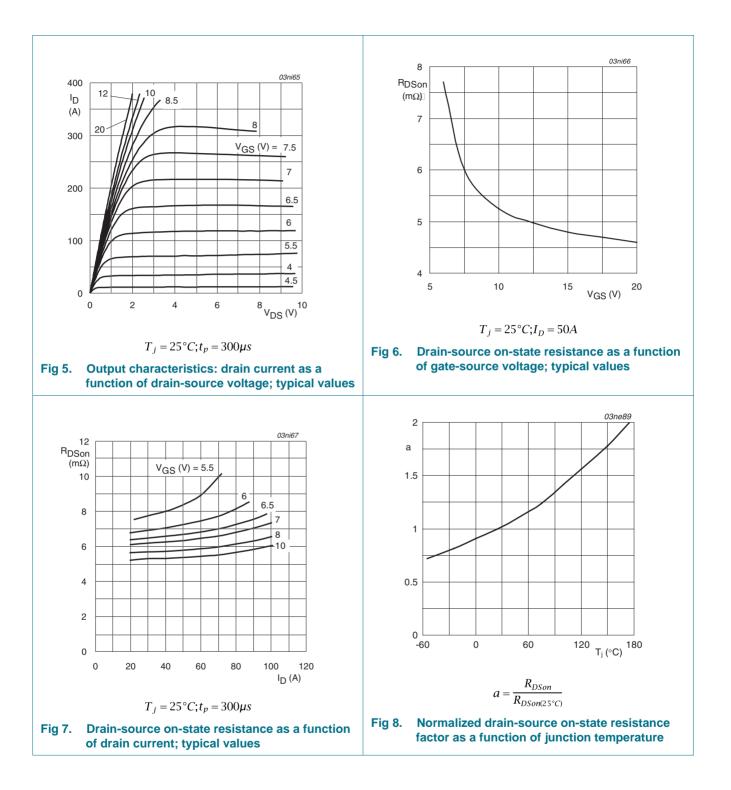
Table 5.	Thermal characteristics	i				
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient	mounted on a PCB; minimum footprint	-	50	-	K/W
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	-	0.55	K/W

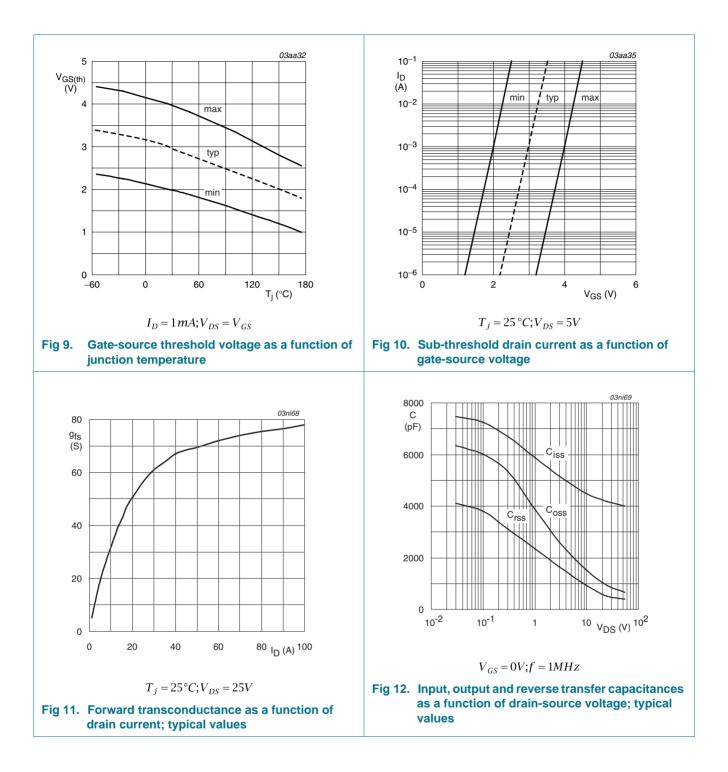


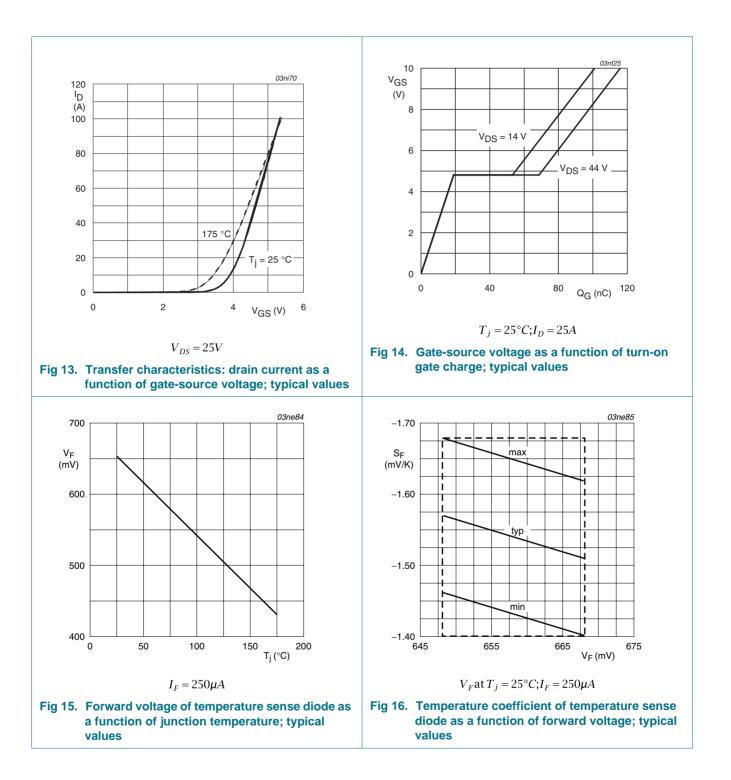
6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V _{(BR)DSS} drain-source		I_D = 0.25 mA; V_{GS} = 0 V; T_j = 25 °C	55	-	-	V
breal	breakdown voltage	I_D = 0.25 mA; V_{GS} = 0 V; T_j = -55 °C	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 9</u>	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see <u>Figure 9</u>	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 9</u>	-	-	4.4	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.1	10	μA
		$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ °C}$	-	-	250	μA
V _{(BR)GSS}	gate-source breakdown	I _G = 1 mA; -55 °C < T _j < 175 °C	20	22	-	V
	voltage	$I_G = -1 \text{ mA}; -55 \text{ °C} < T_j < 175 \text{ °C}$	20	22	-	V
I _{GSS}	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_{j} = 25 ^{\circ}\text{C}$	-	22	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = -10 \text{ V}; T_{j} = 25 ^{\circ}\text{C}$	-	22	1000	nA
		$V_{DS} = 0 \text{ V}; V_{GS} = 10 \text{ V}; T_{j} = 175 ^{\circ}\text{C}$	-	-	10	μA
		$V_{DS} = 0 V; V_{GS} = -10 V; T_j = 175 °C$	-	-	10	μA
R _{DSon} drain-source on-st resistance	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 50 \text{ A}; T_j = 25 \text{ °C};$ see Figure 7; see Figure 8	-	5.8	7	mΩ
		$V_{GS} = 10 \text{ V}; \text{ I}_{D} = 50 \text{ A}; \text{ T}_{j} = 175 \text{ °C};$ see <u>Figure 7</u> ; see <u>Figure 8</u>	-	-	14	mΩ
V _{F(TSD)}	temperature sense diode forward voltage	I _F = 250 μA; T _j = 25 °C	648	658	668	mV
S _{F(TSD)}	temperature sense diode temperature coefficient	I _F = 250 μA; T _j < 175 °C; T _j > -55 °C	-1.4	-1.54	-1.68	mV/K
V _{F(TSD)hys}	temperature sense diode forward voltage hysteresis	125 μA < I _F < 250 μA; T _j = 25 °C	25	32	50	mV
Dynamic o	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 25 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 10 \text{ V};$	-	116	-	nC
Q _{GS}	gate-source charge	see <u>Figure 14</u>	-	19	-	nC
Q_{GD}	gate-drain charge		-	50	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	4500	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 12</u>	-	960	-	pF
C _{rss}	reverse transfer capacitance		-	510	-	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 1.2 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	36	-	ns
t _r	rise time	$R_{G(ext)}$ 10 Ω	-	115	-	ns
t _{d(off)}	turn-off delay time		-	159	-	ns
t _f	fall time		-	111	-	ns

Table 6.	Characteristics continued							
Symbol	Parameter	Conditions	Min	Тур	Max	Unit		
L _D	internal drain inductance	from upper edge of drain mounting base to center of die	-	2.5	-	nH		
L _S	internal source inductance	from source lead to source bond pad	-	7.5	-	nH		
Source-d	rain diode							
V_{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 17</u>	-	0.85	1.2	V		
t _{rr}	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s}; \text{ V}_{GS} = -10 \text{ V};$	-	80	-	ns		
Q _r	recovered charge	$V_{DS} = 30 V$	-	200	-	nC		

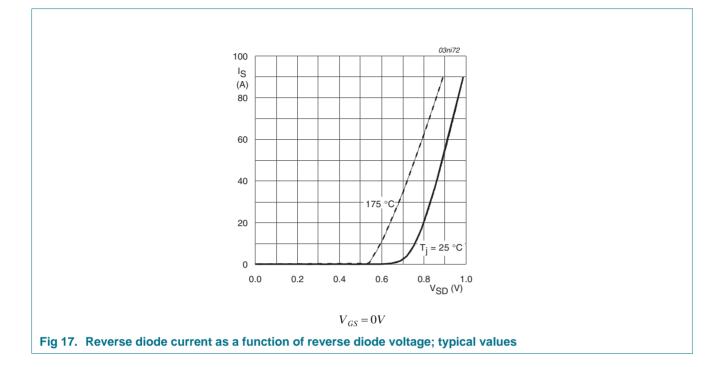






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BUK7107-55ATE



N-channel TrenchPLUS standard level FET

7. Package outline

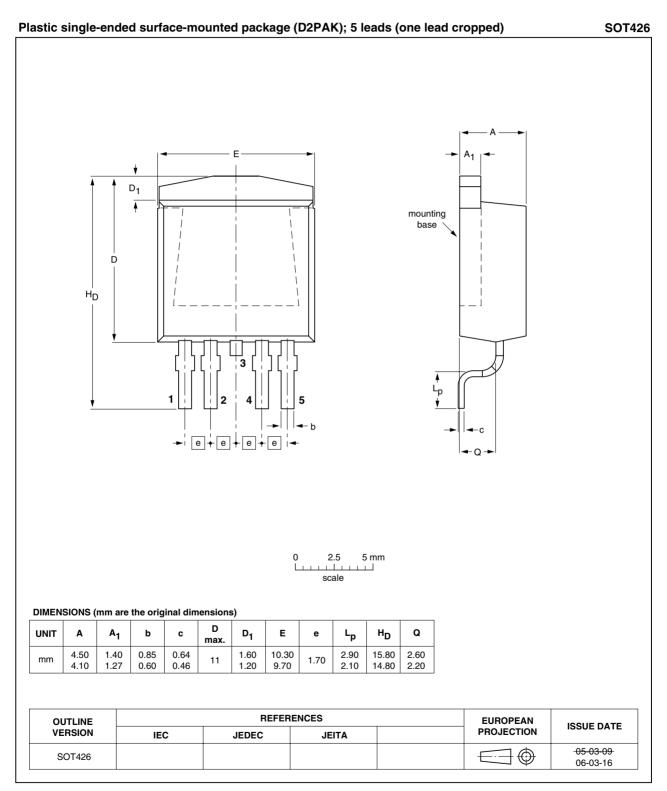


Fig 18. Package outline SOT426 (D2PAK)

8. Revision history

Table 7. Revision his	story			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK7107-55ATE_2	20090219	Product data sheet	-	BUK7107_55ATE-01
Modifications:		t of this data sheet has b of NXP Semiconductors	een redesigned to compl	y with the new identity
	 Legal texts 	have been adapted to the	ne new company name w	vhere appropriate.
BUK7107_55ATE-01 (9397 750 09875)	20020729	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions"

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N-channel TrenchPLUS standard level FET

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